## In the claims:

Claim 1 (currently amended) An apparatus for implanting ions in an aluminum alloy part element (5), comprising a source (6) for delivering ions accelerated by an extraction voltage, and a first adjusting means (7-11) for adjusting an initial beam (fl') of ions emitted by said source (6) into an implantation beam (fl), characterized in that wherein said source (6) is an electron cyclotron source producing multi-energy ions that are implanted in the part element (5) at a temperature below 120°C, the implantation of the multi-energy ions from the implantation beam (fl) being effected simultaneously at a depth controlled by the extraction voltage of the source.

Claim 2 (currently amended) The apparatus as in claim 1, characterized in that wherein it further comprises a second adjusting means (1, 4, 12) for adjusting the relative positions of the part element (5) and the ion source (6).

Claim 3 (currently amended) The apparatus as in claim 2, characterized in that wherein the second adjusting means (1, 4, 12) comprise comprises a part an element holder that is (12) movable (12) so as to displace the part element (5) during its treatment.

Claim 4 (currently amended) The apparatus as in claim 3, characterized in that wherein the part element holder (12) is equipped with cooling means (13) to evacuate the heat generated in the part element (5) during the implantation of the multi-energy ions.

Claim 5 (currently amended) The apparatus as in any one of preceding elaims claim 1 wherein, characterized in that the first adjusting means (7-11) for adjusting the ion beam comprise comprises a mass spectrometer (7) for sorting the ions produced by the source (6) according to their charge and mass.

Claim 6 (currently amended) The apparatus as in any one of the preceding elaims, characterized in that claim 1 wherein the adjusting means (7-11) for adjusting the initial ion beam (fl') further comprise comprises optical focusing means (8), a profiler (9), a current transformer (10) and a shutter (11).

Claim 7 (currently amended) The apparatus as in any one of the preceding elaims, characterized in that claim 1 wherein it is confined in an enclosure (3) equipped with a vacuum pump (2).

Claim 8 (currently amended) The apparatus as in claim 3, characterized-in that wherein the second adjusting means (1, 4, 12) for adjusting the relative positions of the part element (5) and the ion source (6) comprise comprises calculating means (1) for calculating said position on the basis of data related to the nature of the ion beam, the geometry of the part (5), the rate of displacement of the part holder (12) with respect to the source (6), and the number of passes already completed.

Claim 9 (currently amended) A process for treating an aluminum alloy by ion implantation employing an apparatus as in any one of the preceding claims,

characterized in that claim 1 wherein the multi-energy ion beam displaces relatively with respect to the part element (5) at a constant rate.

Claim 10 (currently amended) A process for treating an aluminum alloy by ion implantation employing an apparatus as in any one of claims claim 1 to 8, characterized in that wherein the multi-energy ion beam displaces relatively with respect to the part element (5) at a variable rate that takes into account the angle of incidence of the multi-energy ion beam with respect to the surface of the part element (5).

Claim 11 (currently amended) The treatment process as in either of claims

claim 9 and 10, characterized in that wherein the multi-energy ion beam is emitted at a

constant emission rate and constant emission energies.

Claim 12 (currently amended) The treatment process as in either of claims claim 9 and 10, characterized in that wherein the multi-energy ion beam is emitted at a variable emission energies controlled by the ion source (6).